# Dark Matter-Electron Scattering in the DarkSide-50 Experiment

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The DarkSide-50 Experiment

Dark matter direct detection using an Ar dual-phase TPC

2014 - present

Gran Sasso National Laboratory (LNGS), Italy

50 kg of underground argon

TPC inside 30 t liquid scintillator veto within a 1 kt water Cherenkov detector

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# Dual-phase Ar Time Projection Chamber (TPC)

Calorimetry + 3D position

Energy deposition in LAr produces scintillation photons and free electrons

S1: primary scintillation in LAr (typically used as energy estimator)

S2: secondary scintillation from electroluminescence of electrons in gas pocket



#### S2-Only Analysis

S1 for a low-energy event may not be detectable

- no z position
- no NR/ER discrimination
- S2 is now energy estimator

S2 yield = 23±1 PE/e-

100% trigger efficiency at 1.3 e<sup>-</sup>

trigger: 2 PMTs firing within 100 ns



#### Recent improvements:

- increased statistics (+1.5x 2018 dataset)
- improved data selection

#### DarkSide-50 Calibrations

ER energy scale: <sup>37</sup>Ar decays throughout TPC (τ<sub>1/2</sub> ~ 35 days)

NR energy scale: <sup>241</sup>Am<sup>13</sup>C and <sup>241</sup>AmBe sources

Recent improvements:

- detector effects (radial dependency, geometry)
- reduction of the overall systematic uncertainties

#### <sup>37</sup>Ar calibration



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## DarkSide-50 Backgrounds

# Full simulation of radioactive components

- detector materials (<sup>238</sup>U, <sup>232</sup>Th, <sup>40</sup>K, <sup>60</sup>Co)
- intrinsic to target (<sup>39</sup>Ar, <sup>85</sup>Kr)

#### Multivariate approach fits background components to data

 S1 single scatters, S1 multiple scatters, drift time



Improved background model:

- extended above 50 N
- more accurate pdfs, improved constraints on internals, new calibration

#### Phys. Rev. D 98, 102006 (2018)

#### Background ionization spectra



#### Dark Matter-Argon Interactions





## DM-Electron Scattering

Model observable: differential ionization rate

events / target mass / exposure time

argon ionization form-factor

dark matter velocity distribution

dark matter formfactor ( $F_{DM}$ )



#### Predicted DM-electron scattering rates



DM-Electron Scattering

Model observable: differential ionization rate

> events / target mass / exposure time

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## 90% CL Exclusion Limits

Binned profile likelihood method used to set upper limit on DM cross-section

Significant improvements over 2018 DS-50 limits expected... stay tuned!

#### Significant improvements expected



DarkSide: Phys. Rev. Lett. 121, 111303 (2018) XENON: Phys. Rev. Lett. 123, 251801 (2019)

# Questions?

# **Backup Slides**

#### **DM-Electron Scattering**



#### **DM-Electron Scattering**

$$\begin{split} &\frac{d\langle \sigma_{\rm ion}^{nl} v\rangle}{d\ln E_{\rm er}} = \frac{\overline{\sigma}_e}{8\,\mu_{\chi e}^2} \\ &\times \int dq\,q\,|f_{\rm ion}^{nl}(k',q)|^2\,|F_{\rm DM}(q)|^2\,\eta(v_{\rm min}), \end{split}$$

$$F_{\rm DM}(q) = \frac{m_{A'}{}^2 + \alpha^2 m_e{}^2}{m_{A'}{}^2 + q^2} \simeq \begin{cases} 1, & m_{A'} \gg \alpha m_e \\ \frac{\alpha^2 m_e{}^2}{q^2}, & m_{A'} \ll \alpha m_e \end{cases},$$

$$v_{
m min}(q,E_b^{nl},E_{
m er})=rac{|E_b^{nl}|+E_{
m er}}{q}+rac{q}{2m_\chi}$$

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Scalable

Efficient scintillator

Sensitive to WIMPs over large mass range

Pulse shape discrimination (PSD)











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